Search Notes

1	Application/Control No.	Applicant(s)/Patent under Reexamination
1	10/791,619	LOWMAN ET AL.
E	Examiner	Art Unit
1	Michael Szperka	1644

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Class	Subclass	Date	Examiner
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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STIC sequence search SEQ ID NO:8, 11, and 12		7/24/2006	MS

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
updated inventor search Lowman, Henry Presta, Leonard Jardieu, Paula Lowe, John	7/24/2006	MS		
updated USPAT USPGPUB EPO JPO DERWENT (EAST) see search printouts	7/24/2006	MS		
patentatbility conference with SPEChan; SPE deemed methods allowable with incorporation of functional limitation	8/2/2006	MS		
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